


<b>Search Notes</b> 	<b>Application/Control No.</b> 10789191	<b>Applicant(s)/Patent Under Reexamination</b> WEYRICH ET AL.
	<b>Examiner</b> Lewis, Cheryl	<b>Art Unit</b> 2167

SEARCHED			
Class	Subclass	Date	Examiner
707	3-5, 102, 104.1, 200, and 205	5/11/07	CL
717	174 and 177	5/11/07	CL
705	34 and 40	5/11/07	CL
725	1, 2, and 151	5/11/07	CL

SEARCH NOTES		
Search Notes	Date	Examiner
searched WEST US Patents, JPO Abstracts, EPO Abstracts, Derwent Patents, IBM Disclosure, and Pre-Publications database	5/11/07	CL
searched ACM Library, ProQuest Direct database, and Google scholar	5/11/07	CL
searched Dialog (Ei Compendex, INSPEC, SciSearch(R) Cited Ref Sci, and Computer and Information Systems Abstracts)	5/11/07	CL
consulted with Primary Alford Kindred, AU 2163	5/11/07	CL
Inventor name search	5/11/07	CL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
same as	above	5/11/07	CL